# Power MOSFET

# 30 V, 17 m $\Omega$ , 22 A, Single N-Channel, $\mu$ 8FL

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- · Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C25NWF Wettable Flanks Product
- NVT Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Param	Symbol	Value	Unit			
Drain-to-Source Voltage	V <sub>DSS</sub>	30	V			
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	10.1	Α	
Current R <sub>0JA</sub> (Notes 1, 3, 5)	Steady State	T <sub>A</sub> = 85°C		7.8		
Power Dissipation R <sub>0JA</sub>		T <sub>A</sub> = 25°C	P <sub>D</sub>	3.0	W	
(Notes 1, 3, 5)		T <sub>A</sub> = 85°C		1.8		
Continuous Drain		T <sub>C</sub> = 25°C	I <sub>D</sub>	22.1	Α	
Current R <sub>ψJC</sub> (Notes 1, 2, 4, 5)	Steady State	T <sub>C</sub> = 85°C		17.1		
Power Dissipation					W	
R <sub>ψJC</sub> (Notes 1, 2, 4, 5)		T <sub>C</sub> = 85°C		8.6		
Pulsed Drain Current	I <sub>DM</sub>	90	Α			
Operating Junction and S	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C			
Source Current (Body Did	Is	14	Α			
Single Pulse Drain-to-So (T <sub>J</sub> = 25°C, I <sub>L</sub> = 6.7 A <sub>pk</sub> , L	E <sub>AS</sub>	11.2	mJ			
Lead Temperature for So (1/8" from case for 10 s)	TL	260	°C			

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- The entire application environment impacts the thermal resistance values shown; they are not constants and are valid for the specific conditions noted.
- 2. Psi  $(\psi)$  is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to a single case surface.
- 3. Surface-mounted on FR4 board using 650 mm<sup>2</sup>, 2 oz. Cu Pad.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- Continuous DC current rating. Maximum current for pulses as long as one second is higher but dependent on pulse duration and duty cycle.

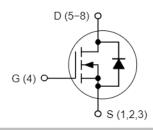


## ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	17 mΩ @ 10 V	22 A
	26.5 mΩ @ 4.5 V	22 A

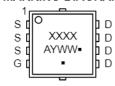
#### N-Channel MOSFET





CASE 511AB

# MARKING DIAGRAM



XXXX = Specific Device Code
A = Assembly Location

Y = Year WW = Work Week • = Pb-Free Package

(Note: Microdot may be in either location)

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Notes 6, 7 and 9)	$\Psi_{ heta  extsf{JC}}$	10.5	°C/W
Junction-to-Ambient - Steady State (Notes 6 and 8)	$R_{\theta JA}$	50	-0/00

- 6. The entire application environment impacts the thermal resistance values shown; they are not constants and are valid for the specific conditions noted.
- 7. Psi (ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to a single case surface.
- 8. Surface-mounted on FR4 board using 650 mm<sup>2</sup>, 2 oz. Cu Pad.
- 9. Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				15.3		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25°C			1.0	μΑ
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 10)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = V_{DS}$	= 250 μΑ	1.3		2.2	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-4.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A		13	17	_
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 9 A		21	26.5	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>E</sub>	) = 15 A		23		S
Gate Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°	С		1.0		Ω
CHARGES AND CAPACITANCES							-
Input Capacitance	C <sub>ISS</sub>				500		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			295		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				85		1
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15 V, f = 1 MHz			0.170		
Total Gate Charge	Q <sub>G(TOT)</sub>				5.1		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.9		
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 1$	5 V; I <sub>D</sub> = 20 A		1.7		
Gate-to-Drain Charge	$Q_{GD}$				2.7		
Gate Plateau Voltage	V <sub>GP</sub>				3.3		V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 1	5 V; I <sub>D</sub> = 20 A		10.3		nC
SWITCHING CHARACTERISTICS (Note 11)							
Turn-On Delay Time	t <sub>d(ON)</sub>				8.0		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 10 A, $R_{G}$ = 3.0 $\Omega$			32		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				10		
Fall Time	t <sub>f</sub>				3.0		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			4.0		
Rise Time	t <sub>r</sub>				25		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				13		ns
Fall Time	t <sub>f</sub>				2.0		

<sup>10.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

<sup>11.</sup> Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>.1</sub> = 25°C unless otherwise specified)

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Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS								
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 10 A	T <sub>J</sub> = 25°C		0.87	1.2	V	
			T <sub>J</sub> = 125°C		0.75		V	
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs, I <sub>S</sub> = 30 A			18.2			
Charge Time	ta				9.8		ns	
Discharge Time	t <sub>b</sub>				8.4			
Reverse Recovery Charge	Q <sub>RR</sub>				5.7		nC	

<sup>10.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 11. Switching characteristics are independent of operating junction temperatures.

#### TYPICAL CHARACTERISTICS

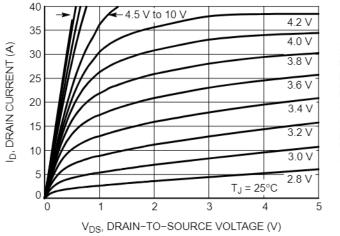


Figure 1. On-Region Characteristics

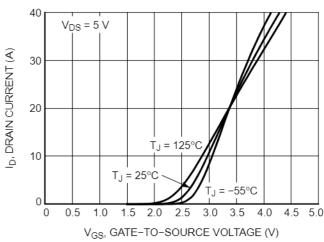


Figure 2. Transfer Characteristics

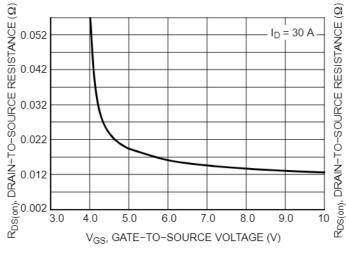


Figure 3. On-Resistance vs. V<sub>GS</sub>

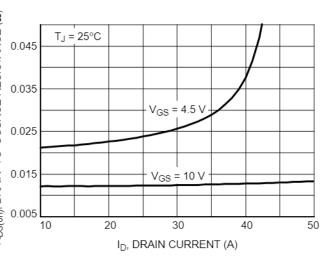


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

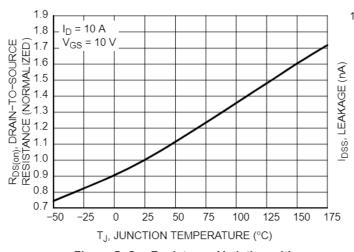


Figure 5. On-Resistance Variation with Temperature

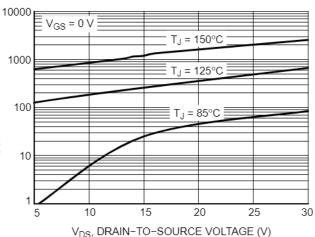
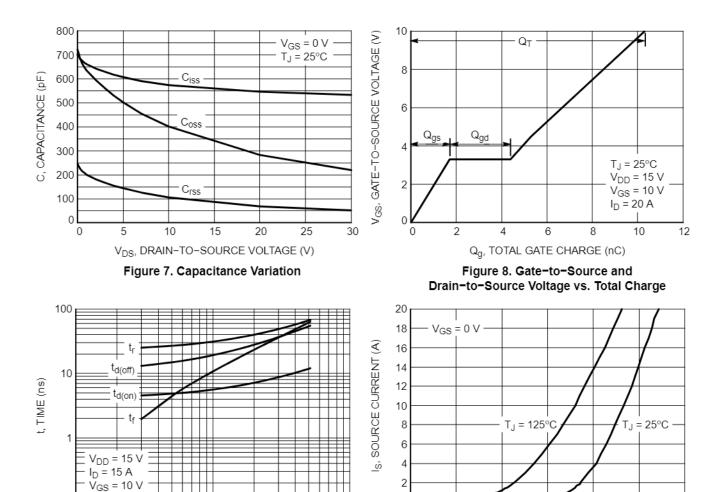


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL CHARACTERISTICS



0

0.4

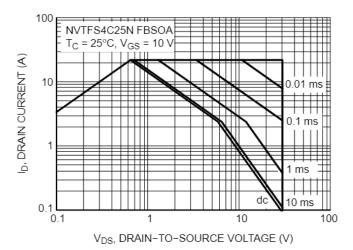
 $\label{eq:RG} \textbf{R}_{G}, \, \text{GATE RESISTANCE} \, (\Omega)$  Figure 9. Resistive Switching Time Variation vs. Gate Resistance

10

0.1

 $\label{eq:VSD} V_{SD}, \, \text{SOURCE-TO-DRAIN VOLTAGE (V)}$  Figure 10. Diode Forward Voltage vs. Current

0.7



100

Figure 11. Maximum Rated Forward Biased Safe Operating Area

#### TYPICAL CHARACTERISTICS

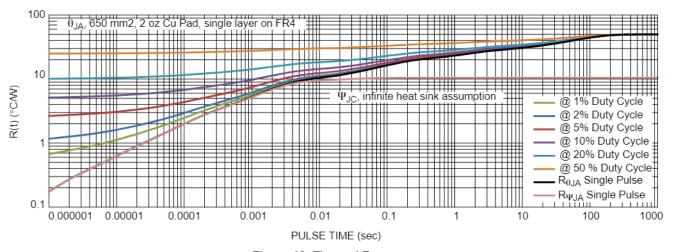


Figure 12. Thermal Response

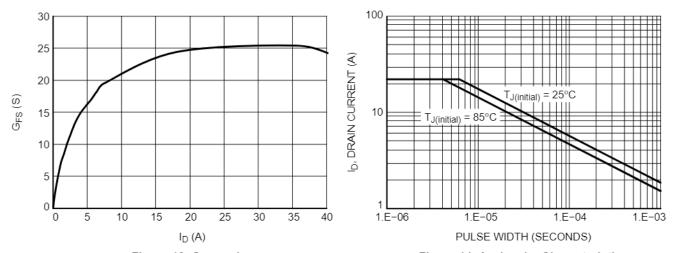


Figure 13. G<sub>FS</sub> vs. I<sub>D</sub>

Figure 14. Avalanche Characteristics

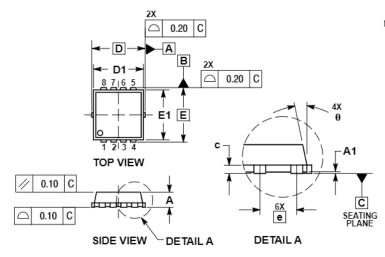
## ORDERING INFORMATION

Device	Marking	Package	Shipping <sup>†</sup>
NVTFS4C25NTAG	4V25	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS4C25NWFTAG	25WF	WDFN8 (Pb-Free)	1500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

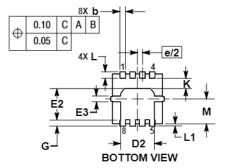
## WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

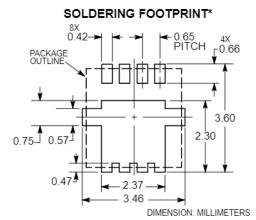


#### NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
- PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D	3.30 BSC			0	.130 BSC	
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC	,	0	.130 BSC	)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
M	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °





\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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